Unusual field dependence of remanent magnetization in granular CrO₂: possible role of piezomagnetism

A. Bajpai, R. Klingeler, N. Wizent, A.K. Nigam, S-W. Cheong, and B. Büchner Leibniz-Institute for Solid State and Materials Research, IFW Dresden, 01171 Dresden, Germany Tata Institute of Fundamental Research, Homi Bhabha Road, Mumbai 400005, India Rutgers Center for Emergent Materials and Department of Physics and Astronomy, Rutgers University, Piscataway, New Jersey, 08854, USA (Dated: July 8, 2008)

We present low field thermoremanent magnetization (TRM) measurements in granular $\rm CrO_2$ and composites of ferromagnetic (FM) $\rm CrO_2$ and antiferromagnetic (AFM) $\rm Cr_2O_3$. TRM in these samples is seen to display two distinct time scales. A quasi static part of remanence, appearing only in low field regime exhibits a peculiar field dependence. TRM is seen to first rise and then fall with increasing cooling fields, eventually vanishing above a critical field. Similar features in TRM have previously been observed in some antiferromagnets that exhibit the phenomenon of piezomagnetism. Scaling analysis of the TRM data suggest that presumably piezomoments generated in the AFM component drive the FM magnetization dynamics in these granular systems in low field regime.

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For granular specimens of half metallic ferromagnet $CrO_2(T_C \approx 393 \text{ K})$, it has been demonstrated earlier that the growth of an insulating oxide Cr₂O₃ naturally occurs on the surface of the CrO₂ grains^{1,2,3}. This makes granular CrO₂ an attractive magnetoresistive material that exhibits spin polarized tunnelling through the network of metallic grains of CrO₂, separated by insulating grain boundary of $Cr_2O_3^{1,2,3}$. This also renders the system a very interesting aspect: a spin polarized metal in contact with a dielectric. It is to be noted that the dielectric under consideration, (i.e. Cr_2O_3) in its bulk form is a well known room temperature AFM ($T_N \approx 307 \text{ K}$) and a prototypical magnetoelectric material^{4,5,6,7}. However, the manner in which its AFM character affects the magnetic and transport properties, when it appears as a grain boundary in granular CrO₂, remains largely unexplored. The primary difficulty arises due to the fact that it is hard to track the subtle change in AFM grain boundary in the presence of strongly ferromagnetic CrO₂, at least through routine magnetization measurements.

A possible means of disentagling the magnetic contribution from FM ${\rm CrO_2}$ and AFM ${\rm Cr_2O_3}$ is to perform thermoremanent magnetization measurements. Study of remanent magnetization (via cooling a magnetic system through its transition temperature under a fixed magnetic field) reveals important information regarding domain motion, pinning mechanisms and other metastable states. The efficiency of these measurements in probing antiferromgnets has been demonstrated earlier^{8,9,10,11,12}.

We investigate granular ${\rm CrO_2}$ in which ${\rm Cr_2O_3}$ appears as a grain boundary, and highly diluted composites of ${\rm CrO_2}$ and ${\rm Cr_2O_3}$ with varying mass fraction of ${\rm Cr_2O_3}$. These sintered pellets have ${\rm CrO_2}$ grains in the form of large micron size rods (5-10 μ m length)^{13,14}. Figure 1a and Figure 1b are the scanning electron micrograph pictures of the sintered pellets, which contain about 10% and 40% mass fraction of ${\rm Cr_2O_3}$ respectively . On the individual ${\rm CrO_2}$ grains (having a well defined rod like

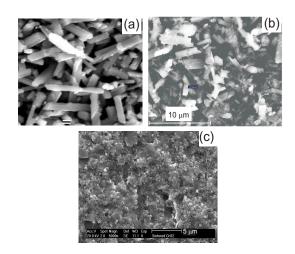


FIG. 1: Scanning electron micrographs for CrO_2 samples containing (a) 10 %, (b) 40 % and (c) 75 % mass fraction of Cr_2O_3 . In (a) and (b), the long micron size rods of CrO_2 grains are visible. On further annealing under high pressure, the grains are seen to coagulate (c).

shape), the antiferromagnetic oxide $\rm Cr_2O_3$ appears as a surface layer (or grain boundary). In this microstructural regime, the samples mimic typical 'metal in insulator scenario' which has also been observed in compacted commercial powders of $\rm CrO_2^{2,3}$. These samples can be termed as 'granular metal' as far as their electron tranport properties are concerned^{2,15}. We also investigate a sample which is further sintered under high pressure (6GPa) and high temperature (upto 700 C). The process of high pressure annealing results in a composite with 75 % mass fraction of $\rm Cr_2O_3$ and more importantly the coagulation of $\rm CrO_2$ grains (Figure 1c). Magnetization measurements on all these samples are done using a Quantum Design SQUID magnetometer.

In granular CrO₂ as well as in highly diluted compos-

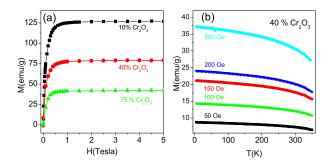


FIG. 2: (a) MH isotherm recorded at 5K for CrO_2 sample with 10 %, 40 % and 75 % mass fraction of Cr_2O_3 . (b) Magnetization as a function of temperature in various magnetic fields between 50 to 500 Oe for the sample with 40 % mass fraction of Cr_2O_3 .

ites, both field and temperature dependence of magnetization (i.e. MH and MT respectively) follow a classical ferromagnetic behaviour arising from $\rm CrO_2$, thus remaining insensitive to the presence of AFM $\rm Cr_2O_3^{15}$. Figure 2a displays MH isotherm measured at 5K for all the three samples. In figure 2b, temperature variation of magnetization measured at various fields for a representative composite with 40 % $\rm Cr_2O_3$ is shown. The magnetization is seen to increase with increasing magnetic field. Similar trend is seen in other two samples.

In Figure 3, we display TRM measurements for all the three samples. The protocol of the TRM measurements is as follows: the sample is cooled from 350 K to 5K in the presence of a fixed magnetic field, hereby referred to as H_{cool} . At 5K, the field is switched off and the remanent magnetization is recorded as a function of temperature in heating cycles. We emphasize that as soon as the magnetic field is switched off, the magnetization is seen to decay almost instantly with time. However, it eventually arrives at some residual value where it stays without a notable decay. For instance, we take note from figure 2b, the 'infield' magnetization value for the 40 % composite, which is around 15 emu/g at 5 K at measuring field of 100 Oe. On switching off the field at 5K, the magnetization attains a residual value of about 5 emu/g (Figure 3b). This 'residual' remanent magnetization is fairly long lived in experimental time scale. What we have plotted in figure 3 is the temperature variation of this quasi static remanence, measured for various H_{cool} .

Figure 3a displays temperature variation of TRM on the sample with 10 % mass fraction of $\rm Cr_2O_3$, for a few selected values of $\rm H_{cool}$. The magnitude of TRM first increases with increasing Hcool and attains its maximum value at a critical cooling field. Above this field, the TRM is seen to decrease in magnitude with increasing $\rm H_{cool}$ and eventually vanishes at cooling fields of about 1 kOe. For all our measurements, the residual field of SQUID magnetometer (which is estimated to be of the order of 2-5 Oe during the measurement) is not seen to interfere with this unusual field dependence of TRM. For the same sample, we also conducted TRM measurements in the

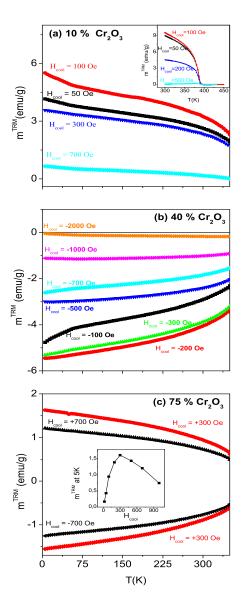


FIG. 3: : (a) TRM as a function of temperature for CrO_2 samples containing (a) 10 % (b) 40 % and (c) 75 % mass fraction of Cr_2O_3 in various H_{cool} . The inset in (a) shows the same in the temperatures between 300 K to 450 K for the 10 % sample. Inset in (c) shows TRM values at 5K plotted as a function of H_{cool} for the sample with 75 % mass fraction of Cr_2O_3 .

high temperature oven in squid magnetometer so as to heat the sample above 400 K (T_C of the FM grain) after each measurement. This data set is displayed in the inset of Figure 3a. Here the H_{cool} was applied at 450 K which is much above the T_C of FM grain and the T_N of the AFM grain boundary. Subsequently, the sample is cooled up to 300 K and the TRM is measured as described earlier. The TRM and its unusual field dependence is seen to persist right up to 400 K, the T_C of FM CrO_2 . Qualitatively similar features are observed when the direction of H_{cool} is reversed.

These experimental signatures are reproduced in com-

posites of CrO₂/Cr₂O₃, irrespective of the mass fraction of Cr₂O₃ or the micostructure, as is evident from Figure 3b and Figure 3c. Figure 3b displays the TRM measured in negative cooling fields for a composite containing 40 % mass fraction of Cr₂O₃. The grain size of CrO₂ in this sample was similar to the sample with 10 % mass fraction of Cr₂O₃. Figure 3c displays the symmetric nature of TRM in positive and negative cooling fields for the 75 % composite. The unusual field dependence of TRM is clearly depicted in the inset of Figure 3c where the TRM at 5K is plotted against the H_{cool} from the cross section of various temperature scans for the 75 % composite. We emphasize that the unusual field dependence of TRM (inset of figure 3c) is qualitatively similar to what is seen in other two samples. However the field at which the TRM reaches its maximum and also the field at which it vanishes, varies slightly from sample to sample. The data obtained on a variety of samples indicate that the peculiar field dependence of TRM is intrinsic to these materials. More importantly, it appears only in the low field limit.

The unusual field dependence of TRM is not reflected in the routine 'in field' magnetization in any of these samples. In all these samples, the magnetization increases in magnitude with increasing applied field (Figure 2b) and saturates at about 1 Tesla (Figure 2a), consistent with FM CrO₂¹⁵. Thus it is clear that while regular M vs T data exhibit no surprises, for the similar measurement protocol, a part of TRM exhibits an unusual field dependence. This field dependence of TRM is strikingly different from what is usually seen in TRM arising in a conventional ferromagnet. It is clear that a part of the remanence, which exhibits instant decay after switching off the field, arises from the regular domain wall dynamics intrinsic to FM CrO₂. However, the quasi static remanance appears to be intimately connected to the magnetization at the AFM/FM interface.

A possible scenario is that the AFM phase pins the FM spins at the interface. However this pinning does not seem to appear from exchange bias alone. Though, exchange bias is certainly expected at the FM/AFM interface but this contribution to TRM should have vanished around 300 K (near the T_N of Cr_2O_3). Moreover, the exchange bias field is inversely proportional to the magnetization of the FM layer¹⁶. It is evident that within this simplistic picture, the peak in TRM at moderate fields of the order of 100 -200 Oe and also vanishing of TRM at fields of the order of 1 -2 kOe can not be understood. Thus, though exchange bias effects at the FM/AFM interface may be present, the observed TRM and the related pinning mechanism does not seem to arise from it. We also recall that a spin flop phase in Cr₂O₃ is known to occur at fields of the order of 5.8 Tesla and temperatures below 90K⁷. However, the unusual field dependence of TRM (in a wide temperature range between 5K-400K) can not be understood by invoking spin flop in the AFM layer. Besides the fact that a field induced spin flop transition is extremely unlikely at such moderate fields, neither the field dependence nor the vanishing of TRM can be explained by this scenario.

It is important to recall that similar features in TRM, especially in low field regime, have previously been observed in certain antiferromagnets whose origin could not be understood within the conventional relaxation processes occurring either in long range order or in the metastable systems^{8,9,10,11,12}. This remanence, has been experimentally observed in Fe_{0.47}ZnO_{0.53}F₂⁸, $Mn_{1-x}Zn_xF_2$, $K_2Fe_{1-x}In_xCl_5$ etc.¹¹ and more recently in the epitaxial thin films of $\mathrm{Cr_2O_3}^{12}$. In case of $\mathrm{FeZnF_2}^8$ as well as pure $\mathrm{Cr_2O_3}$ films¹², this peculiar remanance has been associated with piezomagnetically frozen moments which are, from symmetry arguments, allowed in these antiferromagnets. Here, piezomagnetism is defined as a third rank tensor (P_{ijk}) relating the component of magnetization (M_i) induced in 'i' direction due to the applied stress σ_{jk} (M_i = P_{ijk} σ_{jk})¹⁷. The stress can be applied externally or it can also be intrinsic in the system⁸. In case of epitaxial thin films of Cr₂O₃ stress is understood to arise from the lattice mismatch of the film with the substrate¹². We also emphasize, that in context of spintronic devices based on multiferroic materials which exhibit electric field driven magnetization and magnetic field driven polarization, the phenomenon of piezomagnetism adds additional possibility of strain/stress mediated magnetoelectric coupling¹⁸.

In our CrO₂/Cr₂O₃ samples, we note that the magnitude of TRM obtained is large and it vanishes only above 400 K which is the actual FM T_C , thus indicating that it primarily arises from the ferromagnetic grains. However qualitative features of TRM, particularly its field dependence is remarkably similar to the TRM data obtained on thin films of AFM ${\rm Cr_2O_3}^{12}$. This correlation strongly suggest that at least low field TRM in our samples is modulated by the grain boundary and gives rise to an unconventional pinning mechanism at the FM/AFM interface. It appears that in low field regime, this pinning may arise exclusively due to the piezomoments generated in the AFM Cr₂O₃. These piezomoments can arise due to the natural stress at the interface coming from the lattice mismatch between CrO₂ and Cr₂O₃. This stress can induce a finite piezomoment in the AFM layer as this phenomenon is consistent with the crystal symmetry of Cr_2O_3 . In case of thin films of Cr_2O_3 , the process of field cooling creates AFM domain whose direction is determined by the direction of local stress and the Zeeman energy considerations¹². As in case of thin films of pure Cr₂O₃, these effects appear to peak and saturate in moderate field range of a few 100 Oe. It has been shown in films of Cr₂O₃, that the pinned moment follows similar field dependence (first increasing with increasing field and then saturating at a few 100 Oe) even above the T_N though the magnitude of this effect is smaller¹². The mechanical stress arising due to the lattice mismatch is likely to be finite above T_N . It is also to be recalled that in case of pure Cr₂O₃, the atomic ME coefficient may exist in the paramagnetic regime but the net effect

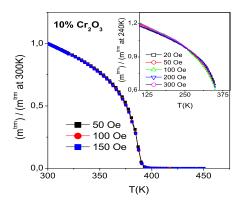


FIG. 4: Main panel shows normalized TRM in the temperature range between 300 to 450 K exhibiting a scaling behaviour in various cooling fields, H_{cool} . The inset shows the normalized TRM for data set recorded between 5K to 350 K. It is seen that for lower H_{cool} , when normalized with any temperature above 200 K, the data collapses into a single curve.

enhances when long range AFM order sets in⁶.

The generation of finite piezomoment in the epitaxial thin films of pure Cr_2O_3 has been concluded from both the functional form, as well as the observation of a scaling behaviour in TRM. Such scaling is understood to arise from the factorization of the piezomoment, due to which magnetization is a product function of field and temperature according to the equation m(H,T) = f(H)g(T) where f and g are functions of field and temperature¹². Scaling is achieved by normalization of moment to its value at any fixed temperature which is less than T_N . Interestingly, we also find that TRM data recorded at various H_{cool} , when normalized by TRM at any temperature above 200K, falls into a single curve. Figure 4 displays TRM normalized to its value measured at 300K for sample with 10 % mass fraction of Cr_2O_3 . The inset shows

the scaling for the TRM measured between 5 K-350 K for the same sample. Here the normalization is done with TRM value measured at 240 K. Deviations from the scaling are observed for $\rm H_{cool}$ more than 200-300 Oe or when TRM is normalized with its value below 200K. Observation of the scaling in this field and temperature window also indicates that possibly similar piezomagnetic traits of AFM $\rm Cr_2O_3$ leads to the unusual magnetization dynamics in granular $\rm CrO_2$.

Once pinned from the process of field cooling through the T_N (307 K) of Cr_2O_3 , the TRM is retained right up to 400 K, and also preserves its peculiar field dependence much above the T_N of Cr_2O_3 . This feature can have interesting implications due to the fact that the magnitude of the pinned moment is significantly large, unlike what is seen in epitaxial thin films of Cr_2O_3 .

In conclusion we present low field thermoremanent magnetization data on the composites of CrO₂/Cr₂O₃. This measurement spectacularly brings out that the effects of magnetization of AFM part, which is not visible in routine 'infield' magnetization in granular CrO₂ sample. The data also indicates that presumably the stress effects, which can naturally occur at the interface of this spin polarized metal (CrO₂) and magnetoelectric insulator (Cr₂O₃) due to the lattice mismatch, may give rise to a finite piezomoment in Cr₂O₃. This, in the low field limit modulates the magnetization of CrO₂. Once frozen from the process of field cooling, these piezomoment can pin the magnetization of FM spins at the interface and thus open up additional possibilities of tuning the spintronic devices via stress mediated coupling in granular CrO_2 .

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